

IRF9530, IRF9531, IRF9532, IRF9533, RF1S9530, RF1S9530SM

10A and -12A, -80V and -100V, 0.3 and 0.4 Ohm, P-Channel Power MOSFETs

January 1998

Features

- -10A and -12A, -80V and -100V
- $r_{DS(ON)} = 0.3\Omega$ and 0.4Ω
- · Single Pulse Avalanche Energy Rated
- SOA is Power Dissipation Limited
- · Nanosecond Switching Speeds
- · Linear Transfer Characteristics
- · High Input Impedance
- · Related Literature
 - TB334, "Guidelines for Soldering Surface Mount Components to PC Boards"

Description

These are P-Channel enhancement mode silicon gate power field effect transistors. They are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching convertors, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. The high input impedance allows these types to be operated directly from integrated circuits.

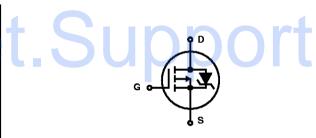
Formerly developmental type TA17511.

Ordering Information

PART NUMBER	PACKAGE	BRAND
IRF9530	TO-220AB	IRF9530
IRF9531	TO-220AB	IRF9531
IRF9532	TO-220AB	IRF9532
IRF9533	TO-220AB	IRF9533
RF1S9530	TO-262AA	RF1S9530
RF1S9530SM	TO-263AB	RF1S9530

NOTE: When ordering, use the entire part number. Add the suffix 9A to obtain the TO-263AB variant in the tape and reel, i.e., RF1S9530SM9A.

Symbol



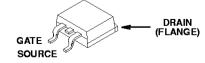
JEDEC TO-262AA

Packaging

JEDEC TO-220AB



JEDEC TO-263A



IRF9530, IRF9531, IRF9532, IRF9533, RF1S9530, RF1S9530SM

Absolute Maximum Ratings T_C = 25°C, Unless Otherwise Specified

- -					
	IRF9530, RF1S9530, RF1S9530SM	IRF9531	IRF9532	IRF9533	UNITS
Drain to Source Breakdown Voltage (Note 1)V _{DS}	-100	-80	-100	-80	٧
Drain to Gate Voltage (R _{GS} = 20kΩ) (Note 1) V _{DGR}	-100	-80	-100	-80	٧
Continuous Drain CurrentID	-12	-12	-10	-10	Α
$T_C = 100^{\circ}C$ I_D	-7.5	-7.5	-6.5	-6.5	Α
Pulsed Drain Current (Note 3)	-48	-48	-40	-40	Α
Gate to Source VoltageV _{GS}	±20	±20	± 20	± 20	٧
Maximum Power DissipationPD	75	75	75	75	W
Dissipation Derating Factor	0.6	0.6	0.6	0.6	W/°C
Single Pulse Avalanche Energy Rating (Note 4) EAS	500	500	500	500	mJ
Operating and Storage Temperature	-55 to 150	-55 to 150	-55 to 150	-55 to 150	°C
Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10s T _L Package Body for 10s, See Techbrief 334 T _{pkg}	•	300 260	300 260	300 260	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $T_J = 25^{\circ}C$ to $T_J = 125^{\circ}C$.

Electrical Specifications $T_C = 25$ °C, Unless Otherwise Specified

PARAMETER	ETER SYMBOL TEST CONDITIONS		MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage IRF9530, IRF9532, RF1S9530, RF1S9530SM	BV _{DSS}	I _D = -250μA, V _{GS} = 0V, (Figure 10)	-100	-	-	٧
IRF9531, IRF9533			-80	-	-	٧
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = -250μA	-2	-	-4	٧
Zero Gate Voltage Drain Current	IDSS	V _{DS} = Rated BV _{DSS} , V _{GS} = 0V	-	-	-25	μΑ
		V_{DS} = 0.8 x Rated BV _{DSS} , V_{GS} = 0V, T_{C} = 125°C	-	-	-250	μΑ
On-State Drain Current (Note 2) IRF9530, IRF9531, RF1S9530, RF1S9530SM	I _{D(ON)}	V _{DS} > I _{D(ON)} × r _{DS(ON)MAX} , V _{GS} = -10V, (Figure 7)		-	-	А
IRF9532, IRF9533			-10	-	-	Α
Gate to Source Leakage Current	IGSS	V _{GS} = ±20V	-	-	±100	пA
Drain to Source On Resistance (Note 2) IRF9530, IRF9531, RF1S9530, RF1S9530SM	^r DS(ON)	I _D = -6.5A, V _{GS} = -10V, (Figures 8, 9)		0.25	0.3	Ω
IRF9532, IRF9533				0.3	0.4	Ω
Forward Transconductance (Note 2)	9fs	$V_{DS} > I_{D(ON)} \times r_{DS(ON)} Max$, $I_D = -6.5A$ (Figure 12)	2	3.8	-	S
Turn-On Delay Time	^t d(ON)	V_{DD} = 50V, $I_D \approx$ -12A, R_G = 50Ω, V_{GS} = 10V R_L = 4.2Ω, (Figures 17, 18) MOSFET Switching Times are Essentially Independent of Operating Temperature		30	60	ns
Rise Time	t _r			70	140	ns
Turn-Off Delay Time	t _{d(off)}			70	140	ns
Fall Time	t _f			70	140	ns
Total Gate Charge (Gate to Source + Gate to Drain)	Q _{g(TOT)}	V _{GS} = -10V, I _D = -12A, V _{DSS} = 0.8 x Rated BV _{DSS} , (Figure 14, 19, 20) Gate Charge	-	25	45	nC
Gate to Source Charge	Q _{gs}	is Essentially Independent of Operating Temperature		13	-	пC
Gate to Drain ("Miller") Charge	Q _{gd}			12	-	пС

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Electrical Specifications $T_C = 25$ °C, Unless Otherwise Specified (Continued)

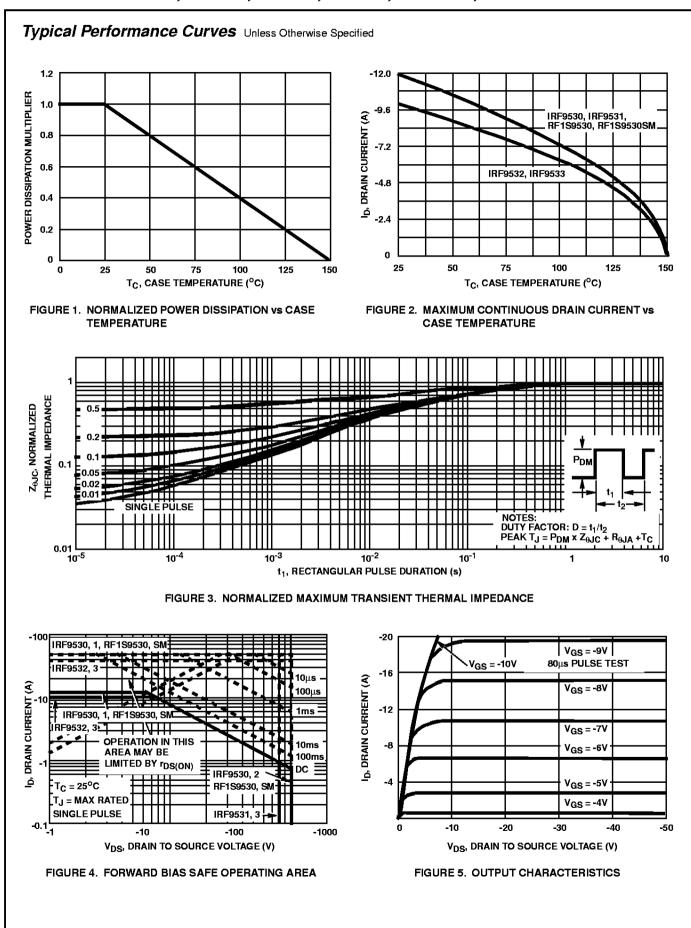
PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Input Capacitance	C _{ISS}	V _{DS} = -25V, V _{GS} = 0V, f = 1MHz, (Figure 11)		-	500	-	pF
Output Capacitance	Coss			-	300	-	pF
Reverse Transfer Capacitance	C _{RSS}			-	100	-	pF
Internal Drain Inductance	L _D	Measured From the Contact Screw On Tab To Center of Die	Modified MOSFET Symbol Showing the Internal Devices Inductances	-	3.5	-	nH
		Measured From the Drain Lead, 6mm (0.25in) From Package to Center of Die		-	4.5	-	nH
Internal Source Inductance	Ls	Measured From The Source Lead, 6mm (0.25in) From Header to Source Bonding Pad		-	7.5	-	nH
Thermal Resistance Junction to Case	R _{0JC}			-	-	1.67	°C/W
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	Typical Socket Mount		-	-	62.5	°C/W

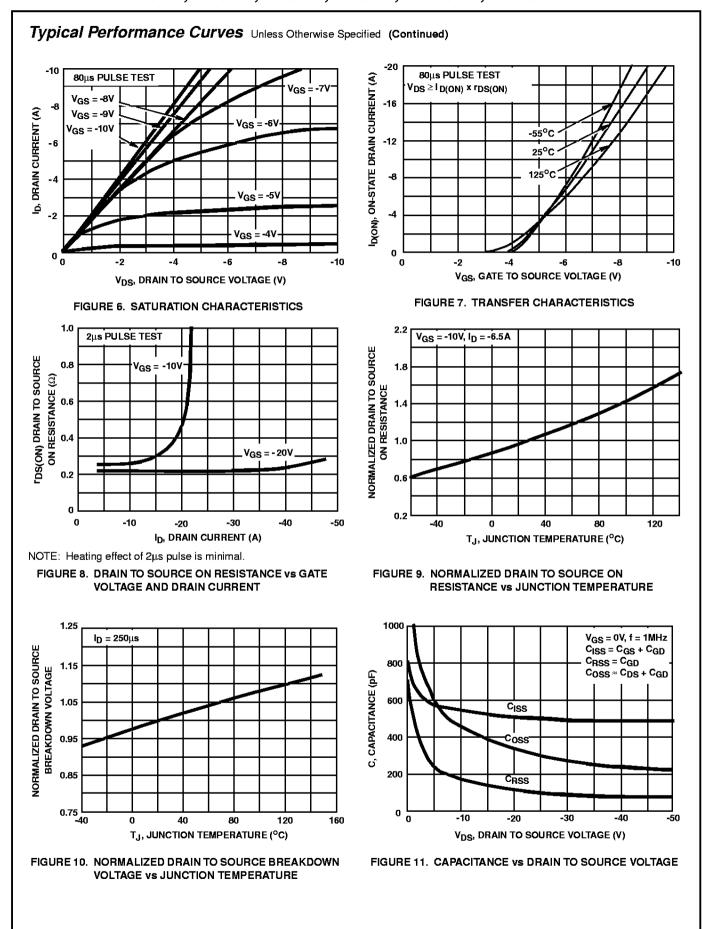
Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I _{SD}	Modified MOSFET	-	-	-12	Α
Pulse Source to Drain Current (Note 2)	ISDM	Symbol Showing the Integral Reverse P-N Junction Diode	-	-	-48	Α
Source to Drain Diode Voltage (Note 2)	V _{SD}	$T_J = 25^{\circ}\text{C}$, $I_{SD} = -12\text{A}$, $V_{GS} = 0\text{V}$, (Figure 13)	-	-	-1.5	٧
Reverse Recovery Time	t _{rr}	T _J = 150°C, I _{SD} = -12A, dI _{SD} /dt = 100A/μs	-	300	-	ns
Reverse Recovery Charge	Q _{RR}	T _J = 150°C, I _{SD} = -12A, dI _{SD} /dt = 100A/μs	-	1.8	-	μC

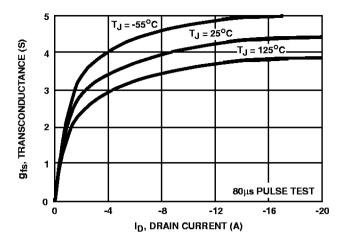
NOTES:

- 2. Pulse test: pulse width ≤ 300 µs, duty cycle ≤ 2%.
- 3. Repetitive rating: pulse width limited by max junction temperature. See Transient Thermal Impedance curve (Figure 3).
- 4. V_{DD} = 25V, starting T_J = 25°C, L = 5.2mH, R_G = 25 Ω , peak I_{AS} = 12A. See Figures 15, 16.





Typical Performance Curves Unless Otherwise Specified (Continued)



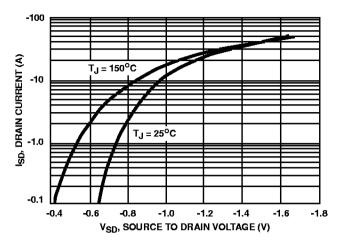


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

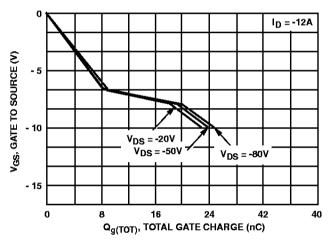


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

Test Circuits and Waveforms

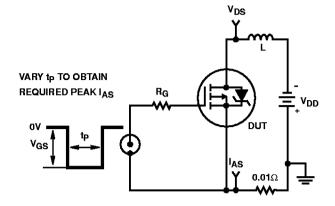


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

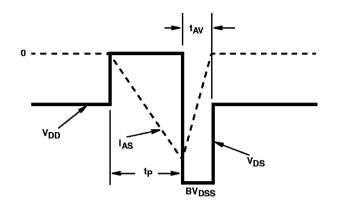


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

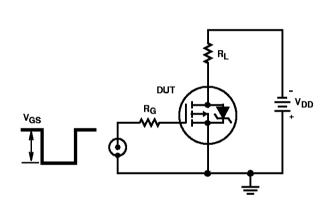


FIGURE 17. SWITCHING TIME TEST CIRCUIT

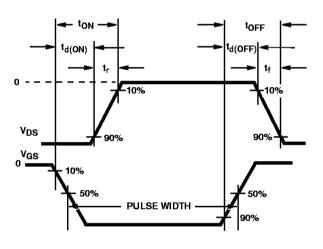


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

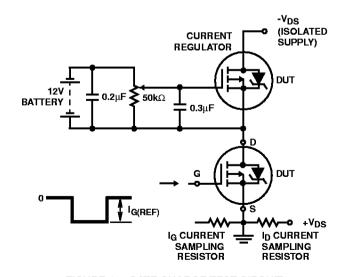


FIGURE 19. GATE CHARGE TEST CIRCUIT

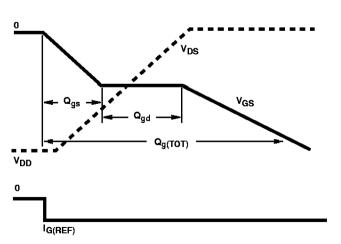


FIGURE 20. GATE CHARGE WAVEFORMS